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Details

Product Status	Obsolete
Core Processor	HC08
Core Size	8-Bit
Speed	8MHz
Connectivity	LINbus, SCI, SPI
Peripherals	POR, PWM
Number of I/O	24
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	512 x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	32-LQFP
Supplier Device Package	32-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc908ey16acfjer

MC68HC908EY16A

MC68HC908EY8A

Data Sheet

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The following revision history table summarizes changes contained in this document. For your convenience, the page number designators have been linked to the appropriate location.

Revision History

Date	Revision Level	Description	Page Number(s)
April, 2006	0	Initial release	N/A
September, 2006	1	21.2 Ordering Information — Separated automotive and consumer/industrial part numbers.	279
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Table of Contents

Chapter 1 General Description

1.1	Introduction	19
1.2	Features	19
1.3	MCU Block Diagram	20
1.4	Pin Assignments	22
1.5	Pin Functions	22
1.5.1	Power Supply Pins (V_{DD} and V_{SS})	22
1.5.2	Oscillator Pins (PTC4/OSC1 and PTC3/OSC2)	23
1.5.3	External Reset Pin (\overline{RST})	23
1.5.4	External Interrupt Pin (\overline{IRQ})	23
1.5.5	Analog Power Supply/Reference Pins (V_{DDA} , V_{REFH} , V_{SSA} , and V_{REFL})	23
1.5.6	Port A I/O Pins (PTA6/ \overline{SS} , PTA5/SPSCK, PTA4/KBD4, PTA3/KBD3/RxD, PTA2/KBD2/TxD, PTA1/KBD1, and PTA0/KBD0)	24
1.5.7	Port B I/O Pins (PTB7/AD7/TBCH1, PTB6/AD6/TBCH0, PTB5/AD5/SPSCK, PTB4/AD4/MO-SI, PTB3/AD3/MISO, PTB2/AD2–PTB0/AD0)	24
1.5.8	Port C I/O Pins (PTC4/OSC1, PTC3/OSC2, PTC2/MCLK/ \overline{SS} , PTC1/MOSI, PTC0/MISO)	24
1.5.9	Port D I/O Pins (PTD1/TACH1–PTD0/TACH0)	24
1.5.10	Port E I/O Pins (PTE1/RxD–PTE0/TxD)	24
1.6	Pin Summary	25
1.7	Priority of Shared Pins	27

Chapter 2 Memory

2.1	Introduction	29
2.2	Unimplemented Memory Locations	29
2.3	Reserved Memory Locations	29
2.4	Input/Output (I/O) Section	29
2.5	Random Access Memory (RAM)	39
2.6	FLASH Memory (FLASH)	39
2.6.1	FLASH Control Register	40
2.6.2	FLASH Page Erase Operation	41
2.6.3	FLASH Mass Erase Operation	42
2.6.4	FLASH Program/Read Operation	43
2.6.5	FLASH Block Protection	45
2.6.6	FLASH Block Protect Register	45
2.6.7	Wait Mode	46
2.6.8	Stop Mode	46

Chapter 3

5.1	Introduction	63
5.2	Functional Description	63

Chapter 6 Computer Operating Properly

6.1	Introduction	69
6.2	Functional Description	69
6.3	I/O Signals	70
6.3.1	CGMXCLK	70
6.3.2	STOP Instruction	70
6.3.3	COPCTL Write	70
6.3.4	Power-On Reset	70
6.3.5	Internal Reset	70
6.3.6	Reset Vector Fetch	70
6.3.7	COPD	70
6.3.8	COPRS	71
6.4	COP Control Register	71
6.5	Interrupts	71
6.6	Monitor Mode	71
6.7	Low-Power Modes	71
6.7.1	Wait Mode	71
6.7.2	Stop Mode	71
6.8	COP Module During Break Interrupts	71

Chapter 7 Central Processor Unit (CPU)

7.1	Introduction	73
7.2	Features	73
7.3	CPU Registers	73
7.3.1	Accumulator	74
7.3.2	Index Register	74
7.3.3	Stack Pointer	75
7.3.4	Program Counter	75
7.3.5	Condition Code Register	76
7.4	Arithmetic/Logic Unit (ALU)	77
7.5	Low-Power Modes	77
7.5.1	Wait Mode	77
7.5.2	Stop Mode	77
7.6	CPU During Break Interrupts	77
7.7	Instruction Set Summary	78
7.8	Opcode Map	83

Chapter 8 Internal Clock Generator (ICG) Module

8.1	Introduction	85
8.2	Features	85

Chapter 3

Analog-to-Digital Converter (ADC10) Module

3.1 Introduction

This section describes the 10-bit successive approximation analog-to-digital converter (ADC10).

The ADC10 module shares its pins with general-purpose input/output (I/O) port pins. See [Figure 3-1](#) for port location of these shared pins. The ADC10 on this MCU uses V_{DDA} and V_{SSA} as its supply pins and V_{REFH} and V_{REFL} as its reference pins. This MCU uses CGMXCLK as its alternate clock source for the ADC. This MCU does not have a hardware conversion trigger.

3.2 Features

Features of the ADC10 module include:

- Linear successive approximation algorithm with 10-bit resolution
- Output formatted in 10- or 8-bit right-justified format
- Single or continuous conversion (automatic power-down in single conversion mode)
- Configurable sample time and conversion speed (to save power)
- Conversion complete flag and interrupt
- Input clock selectable from up to three sources
- Operation in wait and stop modes for lower noise operation

3.3 Functional Description

The ADC10 uses successive approximation to convert the input sample taken from ADVIN to a digital representation. The approximation is taken and then rounded to the nearest 10- or 8-bit value to provide greater accuracy and to provide a more robust mechanism for achieving the ideal code-transition voltage.

[Figure 3-2](#) shows a block diagram of the ADC10.

For proper conversion, the voltage on ADVIN must fall between V_{REFH} and V_{REFL} . If ADVIN is equal to or exceeds V_{REFH} , the converter circuit converts the signal to \$3FF for a 10-bit representation or \$FF for a 8-bit representation. If ADVIN is equal to or less than V_{REFL} , the converter circuit converts it to \$000. Input voltages between V_{REFH} and V_{REFL} are straight-line linear conversions.

NOTE

Input voltage must not exceed the analog supply voltages.

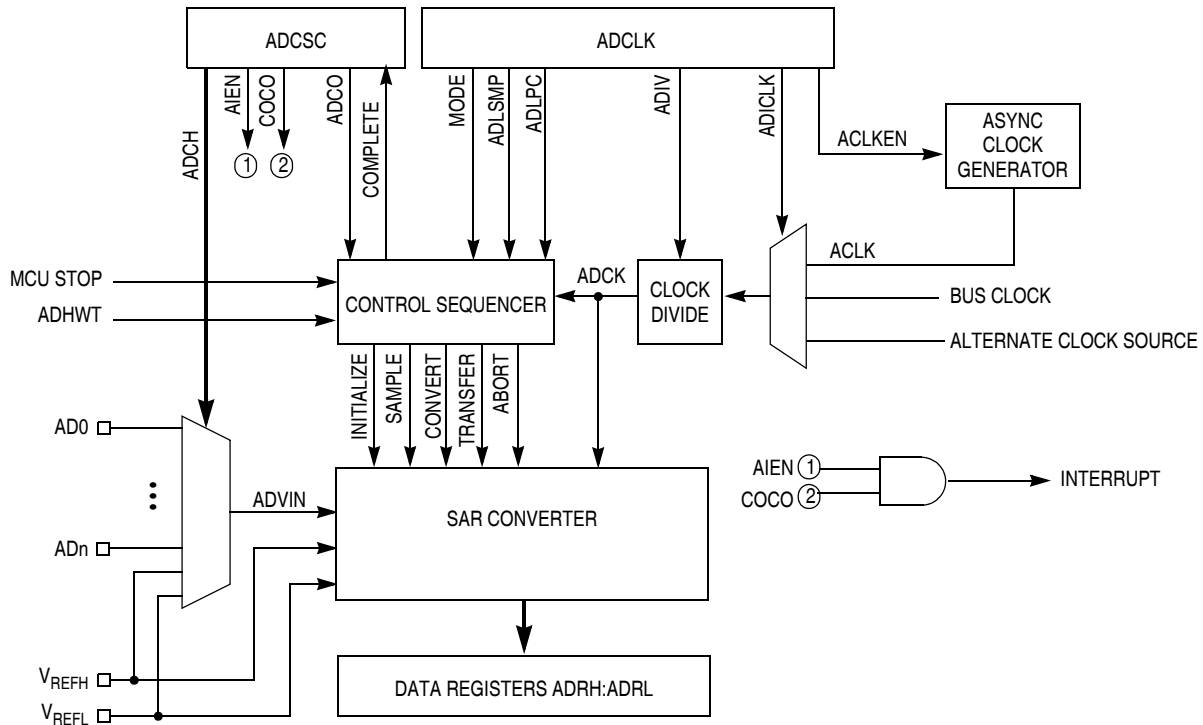


Figure 3-2. ADC10 Block Diagram

The ADC10 can perform an analog-to-digital conversion on one of the software selectable channels. The output of the input multiplexer (ADVIN) is converted by a successive approximation algorithm into a 10-bit digital result. When the conversion is completed, the result is placed in the data registers (ADRH and ADRL). In 8-bit mode, the result is rounded to 8 bits and placed in ADRL. The conversion complete flag is then set and an interrupt is generated if the interrupt has been enabled.

3.3.1 Clock Select and Divide Circuit

The clock select and divide circuit selects one of three clock sources and divides it by a configurable value to generate the input clock to the converter (ADCK). The clock can be selected from one of the following sources:

- The asynchronous clock source (ACLK) — This clock source is generated from a dedicated clock source which is enabled when the ADC10 is converting and the clock source is selected by setting the ACLKEN bit. When the ADLPC bit is clear, this clock operates from 1–2 MHz; when ADLPC is set it operates at 0.5–1 MHz. This clock is not disabled in STOP and allows conversions in stop mode for lower noise operation.
- Alternate clock source — This clock source is equal to the external oscillator clock or a four times the bus clock. The alternate clock source is MCU specific, see [3.1 Introduction](#) to determine source and availability of this clock source option. This clock is selected when ADICK and ACLKEN are both low.
- The bus clock — This clock source is equal to the bus frequency. This clock is selected when ADICK is high and ACLKEN is low.

Whichever clock is selected, its frequency must fall within the acceptable frequency range for ADCK. If the available clocks are too slow, the ADC10 will not perform according to specifications. If the available clocks are too fast, then the clock must be divided to the appropriate frequency. This divider is specified by the ADIV[1:0] bits and can be divide-by 1, 2, 4, or 8.

3.3.2 Input Select and Pin Control

Only one analog input may be used for conversion at any given time. The channel select bits in ADCSC are used to select the input signal for conversion.

3.3.3 Conversion Control

Conversions can be performed in either 10-bit mode or 8-bit mode as determined by the MODE bits. Conversions can be initiated by either a software or hardware trigger. In addition, the ADC10 module can be configured for low power operation, long sample time, and continuous conversion.

3.3.3.1 Initiating Conversions

A conversion is initiated:

- Following a write to ADCSC (with ADCH bits not all 1s) if software triggered operation is selected.
- Following a hardware trigger event if hardware triggered operation is selected.
- Following the transfer of the result to the data registers when continuous conversion is enabled.

If continuous conversions are enabled a new conversion is automatically initiated after the completion of the current conversion. In software triggered operation, continuous conversions begin after ADCSC is written and continue until aborted. In hardware triggered operation, continuous conversions begin after a hardware trigger event and continue until aborted.

3.3.3.2 Completing Conversions

A conversion is completed when the result of the conversion is transferred into the data result registers, ADRH and ADRL. This is indicated by the setting of the COCO bit. An interrupt is generated if AIEN is high at the time that COCO is set.

A blocking mechanism prevents a new result from overwriting previous data in ADRH and ADRL if the previous data is in the process of being read while in 10-bit mode (ADRH has been read but ADRL has not). In this case the data transfer is blocked, COCO is not set, and the new result is lost. When a data transfer is blocked, another conversion is initiated regardless of the state of ADCO (single or continuous conversions enabled). If single conversions are enabled, this could result in several discarded conversions and excess power consumption. To avoid this issue, the data registers must not be read after initiating a single conversion until the conversion completes.

3.3.3.3 Aborting Conversions

Any conversion in progress will be aborted when:

- A write to ADCSC occurs (the current conversion will be aborted and a new conversion will be initiated, if ADCH are not all 1s).
- A write to ADCLK occurs.
- The MCU is reset.
- The MCU enters stop mode with ACLK not enabled.

3.3.4 Sources of Error

Several sources of error exist for ADC conversions. These are discussed in the following sections.

3.3.4.1 Sampling Error

For proper conversions, the input must be sampled long enough to achieve the proper accuracy. Given the maximum input resistance of approximately 15 k Ω and input capacitance of approximately 10 pF, sampling to within 1/4LSB (at 10-bit resolution) can be achieved within the minimum sample window (3.5 cycles / 2 MHz maximum ADCK frequency) provided the resistance of the external analog source (R_{AS}) is kept below 10 k Ω . Higher source resistances or higher-accuracy sampling is possible by setting ADLSMP (to increase the sample window to 23.5 cycles) or decreasing ADCK frequency to increase sample time.

3.3.4.2 Pin Leakage Error

Leakage on the I/O pins can cause conversion error if the external analog source resistance (R_{AS}) is high. If this error cannot be tolerated by the application, keep R_{AS} lower than $V_{ADVIN} / (4096 * I_{Leak})$ for less than 1/4LSB leakage error (at 10-bit resolution).

3.3.4.3 Noise-Induced Errors

System noise which occurs during the sample or conversion process can affect the accuracy of the conversion. The ADC10 accuracy numbers are guaranteed as specified only if the following conditions are met:

- There is a 0.1 μ F low-ESR capacitor from V_{REFH} to V_{REFL} (if available).
- There is a 0.1 μ F low-ESR capacitor from V_{DDA} to V_{SSA} (if available).
- If inductive isolation is used from the primary supply, an additional 1 μ F capacitor is placed from V_{DDA} to V_{SSA} (if available).
- V_{SSA} and V_{REFL} (if available) is connected to V_{SS} at a quiet point in the ground plane.
- The MCU is placed in wait mode immediately after initiating the conversion (next instruction after write to ADCSC).
- There is no I/O switching, input or output, on the MCU during the conversion.

There are some situations where external system activity causes radiated or conducted noise emissions or excessive V_{DD} noise is coupled into the ADC10. In these cases, or when the MCU cannot be placed in wait or I/O activity cannot be halted, the following recommendations may reduce the effect of noise on the accuracy:

- Place a 0.01 μ F capacitor on the selected input channel to V_{REFL} or V_{SSA} (if available). This will improve noise issues but will affect sample rate based on the external analog source resistance.
- Operate the ADC10 in stop mode by setting ACLKEN, selecting the channel in ADCSC, and executing a STOP instruction. This will reduce V_{DD} noise but will increase effective conversion time due to stop recovery.
- Average the input by converting the output many times in succession and dividing the sum of the results. Four samples are required to eliminate the effect of a 1LSB, one-time error.
- Reduce the effect of synchronous noise by operating off the asynchronous clock (ACLKEN=1) and averaging. Noise that is synchronous to the ADCK cannot be averaged out.

break, the bit cannot change during the break state as long as BCFE is cleared. After the break, doing the second step clears the status bit.

3.7 I/O Signals

The ADC10 module shares its pins with general-purpose input/output (I/O) port pins. See [Figure 3-1](#) for port location of these shared pins. The ADC10 on this MCU uses V_{DD} and V_{SS} as its supply and reference pins. This MCU does not have an external trigger source.

3.7.1 ADC10 Analog Power Pin (V_{DDA})

The ADC10 analog portion uses V_{DDA} as its power pin. In some packages, V_{DDA} is connected internally to V_{DD} . If externally available, connect the V_{DDA} pin to the same voltage potential as V_{DD} . External filtering may be necessary to ensure clean V_{DDA} for good results.

NOTE

If externally available, route V_{DDA} carefully for maximum noise immunity and place bypass capacitors as near as possible to the package.

3.7.2 ADC10 Analog Ground Pin (V_{SSA})

The ADC10 analog portion uses V_{SSA} as its ground pin. In some packages, V_{SSA} is connected internally to V_{SS} . If externally available, connect the V_{SSA} pin to the same voltage potential as V_{SS} .

In cases where separate power supplies are used for analog and digital power, the ground connection between these supplies should be at the V_{SSA} pin. This should be the only ground connection between these supplies if possible. The V_{SSA} pin makes a good single point ground location.

3.7.3 ADC10 Voltage Reference High Pin (V_{REFH})

V_{REFH} is the power supply for setting the high-reference voltage for the converter. In some packages, V_{REFH} is connected internally to V_{DDA} . If externally available, V_{REFH} may be connected to the same potential as V_{DDA} , or may be driven by an external source that is between the minimum V_{DDA} spec and the V_{DDA} potential (V_{REFH} must never exceed V_{DDA}).

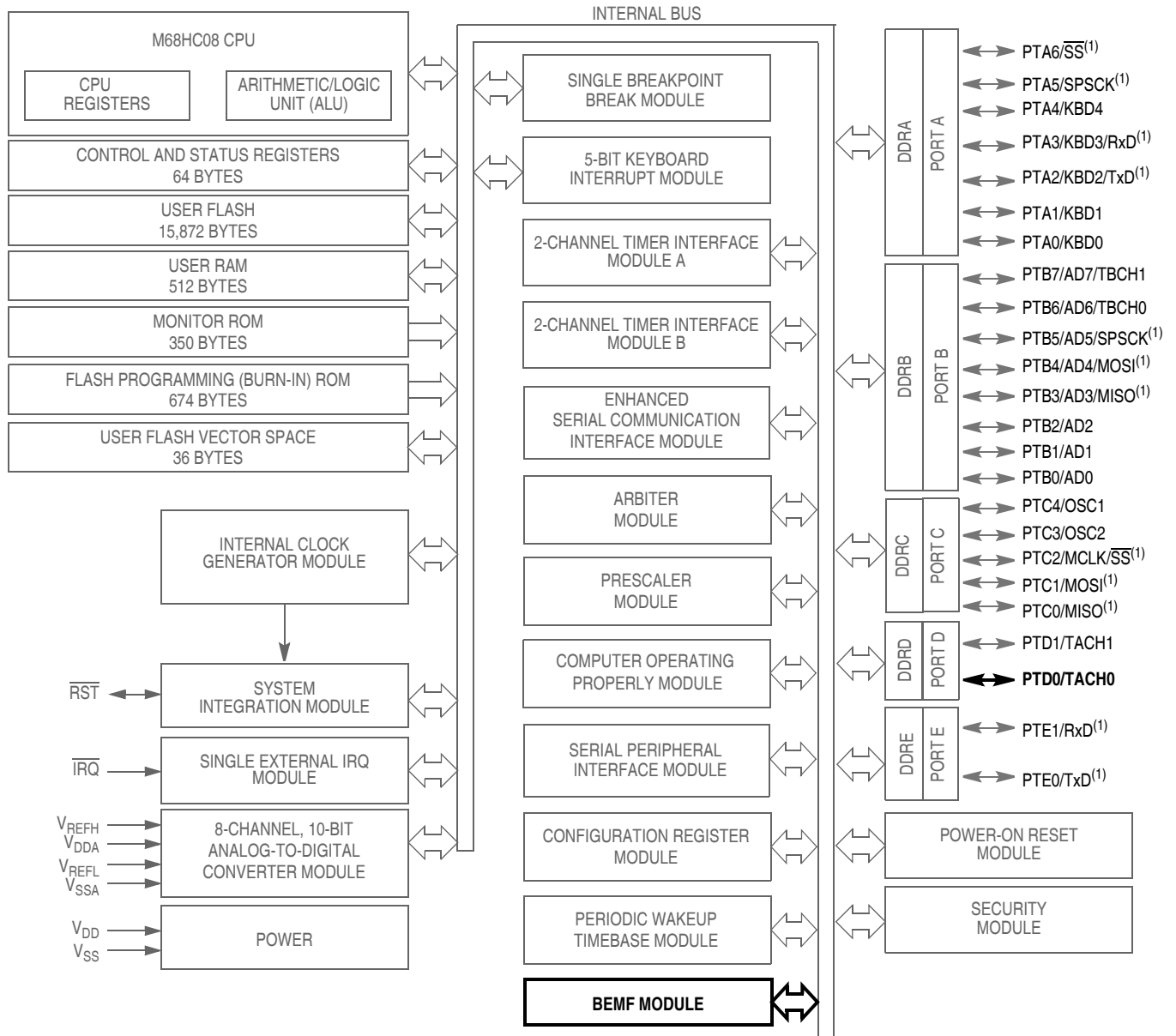
NOTE

Route V_{REFH} carefully for maximum noise immunity and place bypass capacitors as near as possible to the package.

AC current in the form of current spikes required to supply charge to the capacitor array at each successive approximation step is drawn through the V_{REFH} and V_{REFL} loop. The best external component to meet this current demand is a 0.1 μF capacitor with good high frequency characteristics. This capacitor is connected between V_{REFH} and V_{REFL} and must be placed as close as possible to the package pins. Resistance in the path is not recommended because the current will cause a voltage drop which could result in conversion errors. Inductance in this path must be minimum (parasitic only).

3.7.4 ADC10 Voltage Reference Low Pin (V_{REFL})

V_{REFL} is the power supply for setting the low-reference voltage for the converter. In some packages, V_{REFL} is connected internally to V_{SSA} . If externally available, connect the V_{REFL} pin to the same voltage potential as V_{SSA} . There will be a brief current associated with V_{REFL} when the sampling capacitor is



NOTE:

1. The locations of the ESCI and SPI pins are user selectable using CONFIG3 option bits.

Figure 4-2. Block Diagram Highlighting BEMF Block and Pins

4.5.2 Stop Mode

The BEMF module is inactive after execution of the STOP instruction. In stop mode the BEMF register is not accessible by the CPU.

EXTXTALEN, when set, also configures the external clock stabilization divider in the clock monitor for a 4096-cycle timeout to allow the proper stabilization time for a crystal. When EXTXTALEN is clear, the stabilization divider is configured to 16 cycles since an external clock source does not need a startup time.

- 1 = Allows PTC3/OSC2 to be an external crystal connection.
- 0 = PTC3/OSC2 functions as an I/O port pin (default).

EXTSLOW — Slow External Crystal Enable Bit

The EXTSLOW bit has two functions. It configures the ICG module for a fast (1 MHz to 32 MHz) or slow (30 kHz to 100 kHz) speed crystal. The option also configures the clock monitor operation in the ICG module to expect an external frequency higher (307.2 kHz to 32 MHz) or lower (60 Hz to 307.2 kHz) than the base frequency of the internal oscillator. See [Chapter 8 Internal Clock Generator \(ICG\) Module](#).

- 1 = ICG set for slow external crystal operation
- 0 = ICG set for fast external crystal operation

Table 5-1. External Clock Option Settings

External Clock Configuration Bits		Pin Function		Description
EXTCLKEN	EXTXTALEN	PTC4/OSC1	PTC3/OSC2	
0	0	PTC4	PTC3	Default setting — external oscillator disabled
0	1	PTC4	PTC3	External oscillator disabled since EXTCLKEN not set
1	0	OSC1	PTC3	External oscillator configured for an external clock source input (square wave) on OSC1
1	1	OSC1	OSC2	External oscillator configured for an external crystal configuration on OSC1 and OSC2. System will also operate with square-wave clock source in OSC1.

EXTCLKEN — External Clock Enable Bit

EXTCLKEN enables an external clock source or crystal/ceramic resonator to be used as a clock input. Setting this bit enables PTC4/OSC1 pin to be a clock input pin. Clearing this bit (default setting) allows the PTC4/OSC1 and PTC3/OSC2 pins to function as general-purpose input/output (I/O) pins. Refer to [Table 5-1](#) for configuration options for the external source. See [Chapter 8 Internal Clock Generator \(ICG\) Module](#) for a more detailed description of the external clock operation.

- 1 = Allows PTC4/OSC1 to be an external clock connection
- 0 = PTC4/OSC1 and PTC3/OSC2 function as I/O port pins (default).

TMBCLKSEL — Timebase Clock Select Bit

TMBCLKSEL enables an enable the extra divide by 128 prescaler in the timebase module. Setting this bit enables the extra prescaler and clearing this bit disables it. Refer to [Table 16-1](#) for timebase divider selection details.

- 1 = Enables extra divide by 128 prescaler in timebase module.
- 0 = Disables extra divide by 128 prescaler in timebase module.

Chapter 7

Central Processor Unit (CPU)

7.1 Introduction

The M68HC08 CPU (central processor unit) is an enhanced and fully object-code-compatible version of the M68HC05 CPU. The *CPU08 Reference Manual* (document order number CPU08RM/AD) contains a description of the CPU instruction set, addressing modes, and architecture.

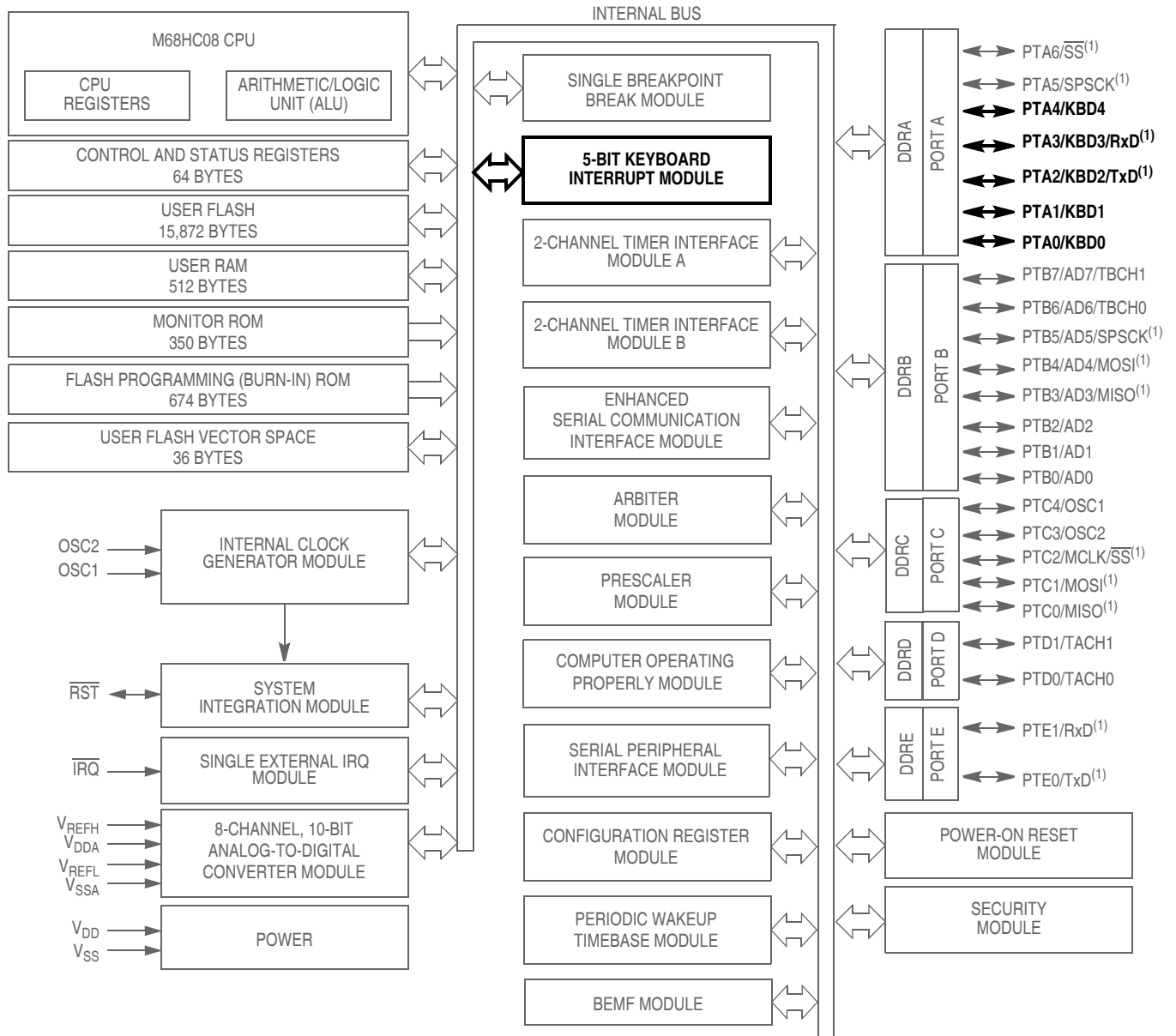
7.2 Features

Features of the CPU include:

- Object code fully upward-compatible with M68HC05 Family
- 16-bit stack pointer with stack manipulation instructions
- 16-bit index register with x-register manipulation instructions
- 8-MHz CPU internal bus frequency
- 64-Kbyte program/data memory space
- 16 addressing modes
- Memory-to-memory data moves without using accumulator
- Fast 8-bit by 8-bit multiply and 16-bit by 8-bit divide instructions
- Enhanced binary-coded decimal (BCD) data handling
- Modular architecture with expandable internal bus definition for extension of addressing range beyond 64 Kbytes
- Low-power stop and wait modes

7.3 CPU Registers

Figure 7-1 shows the five CPU registers. CPU registers are not part of the memory map.



NOTE:

1. The locations of the ESCI and SPI pins are user selectable using CONFIG3 option bits.

Figure 10-1. Block Diagram Highlighting KBI Block and Pins

PTC[4:0] — Port C Data Bits

These read/write bits are software-programmable. Data direction of each port C pin is under the control of the corresponding bit in data direction register C. Reset has no effect on port C data.

12.4.2 Data Direction Register C

Data direction register C determines whether each port C pin is an input or an output. Writing a 1 to a DDRC bit enables the output buffer for the corresponding port C pin; a 0 disables the output buffer.

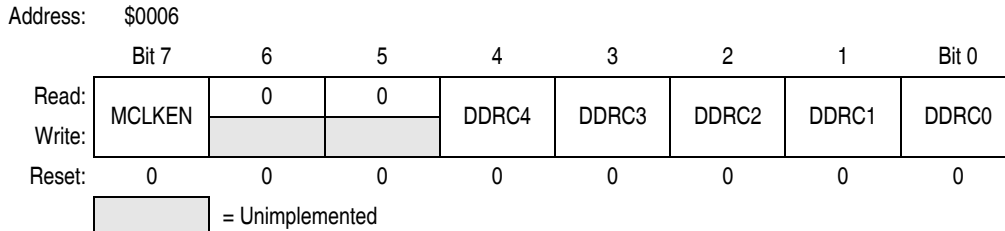


Figure 12-8. Data Direction Register C (DDRC)

MCLKEN — MCLK Enable Bit

This read/write bit enables MCLK, a bus clock frequency clock signal, to be an output signal on PTC2. If MCLK is enabled, PTC2 is under the control of MCLKEN. Reset clears this bit.

- 1 = MCLK output enabled
- 0 = MCLK output disabled

DDRC[4:0] — Data Direction Register C Bits

These read/write bits control port C data direction. Reset clears DDRC[4:0] and MCLKEN, configuring all port C pins as inputs.

- 1 = Corresponding port C pin configured as output
- 0 = Corresponding port C pin configured as input

NOTE

Avoid glitches on port C pins by writing to the port C data register before changing data direction register C bits from 0 to 1.

Figure 12-9 shows the port C I/O logic.

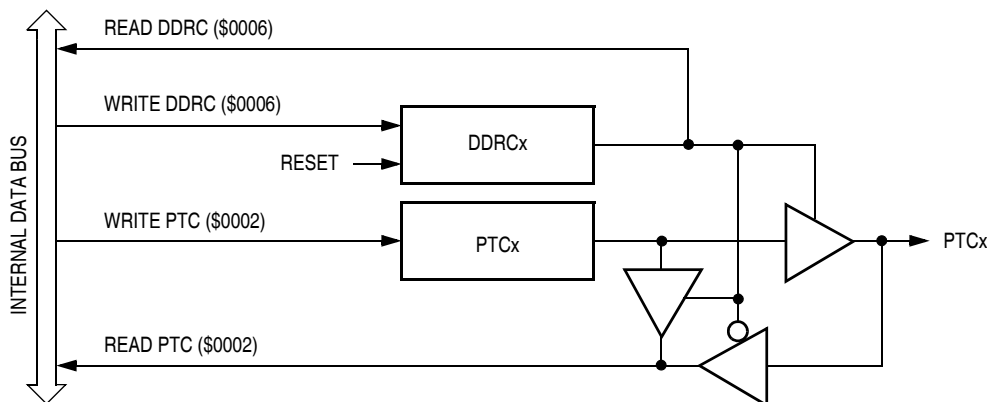


Figure 12-9. Port C I/O Circuit

14.2.1 Bus Timing

In user mode, the internal bus frequency is the internal clock generator output (CGMXCLK) divided by four.

14.2.2 Clock Startup from POR or LVI Reset

When the power-on reset (POR) module or the low-voltage inhibit (LVI) module generates a reset, the clocks to the CPU and peripherals are inactive and held in an inactive phase until after 4096 CGMXCLK cycles. The MCU is held in reset by the SIM during this entire period. The bus clocks start upon completion of the timeout.

14.2.3 Clocks in Stop Mode and Wait Mode

Upon exit from stop mode by an interrupt or reset, the SIM allows CGMXCLK to clock the SIM counter. The CPU and peripheral clocks do not become active until after the stop delay timeout. Stop mode recovery timing is discussed in detail in [14.7.2 Stop Mode](#).

In wait mode, the CPU clocks are inactive. Refer to the wait mode subsection of each module to see if the module is active or inactive in wait mode. Some modules can be programmed to be active in wait mode.

14.3 Reset and System Initialization

The MCU has these internal reset sources:

- Power-on reset (POR) module
- Computer operating properly (COP) module
- Low-voltage inhibit (LVI) module
- Illegal opcode
- Illegal address
- Forced monitor mode entry reset (MENRST) module

All of these resets produce the vector \$FFFE–\$FFFF (\$FEFE–\$FEFF in monitor mode) and assert the internal reset signal (IRST). IRST causes all registers to be returned to their default values and all modules to be returned to their reset states.

These internal resets clear the SIM counter and set a corresponding bit in the SIM reset status register (SRSR). See [14.4 SIM Counter](#) and [14.8.2 SIM Reset Status Register](#).

14.3.1 External Pin Reset

The $\overline{\text{RST}}$ pin circuits include an internal pullup device. Pulling the asynchronous $\overline{\text{RST}}$ pin low halts all processing. The PIN bit of the SIM reset status register (SRSR) is set as long as $\overline{\text{RST}}$ is held low for at least the minimum of t_{ILR} time. [Figure 14-3](#) shows the relative timing.

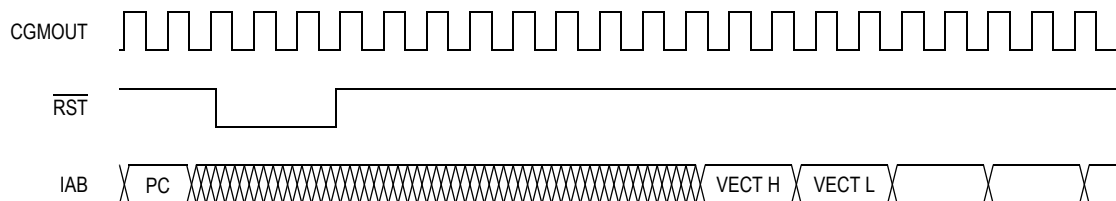


Figure 14-3. External Reset Timing

Chapter 15

Serial Peripheral Interface (SPI) Module

15.1 Introduction

This section describes the serial peripheral interface (SPI) module, which allows full-duplex, synchronous, serial communications with peripheral devices.

15.2 Features

Features of the SPI module include:

- Full-duplex operation
- Master and slave modes
- Double-buffered operation with separate transmit and receive registers
- Four master mode frequencies (maximum = bus frequency ÷ 2)
- Maximum slave mode frequency = bus frequency
- Serial clock with programmable polarity and phase
- Two separately enabled interrupts with CPU service:
 - SPRF (SPI receiver full)
 - SPTE (SPI transmitter empty)
- Mode fault error flag with CPU interrupt capability
- Overflow error flag with CPU interrupt capability
- Programmable wired-OR mode
- I²C (inter-integrated circuit) compatibility

15.3 Pin Name and Register Name Conventions

The generic names of the SPI input/output (I/O) pins are:

- \overline{SS} (slave select)
- SPSCCK (SPI serial clock)
- MOSI (master out slave in)
- MISO (master in slave out)

The SPI shares four I/O pins with a parallel I/O port. The full name of an SPI pin reflects the name of the shared port pin. [Table 15-1](#) shows the full names of the SPI I/O pins. The generic pin names appear in the text that follows.

Table 15-1. Pin Name Conventions

SPI Generic Pin Name	MISO	MOSI	\overline{SS}	SPSCCK
Full SPI Pin Name	PTC0/MISO	PTC1/MOSI	PTA6/ \overline{SS}	PTA5/SPSCCK
Alternative Pin	PTB3	PTB4	PTC2	PTB5

By recording the times for successive edges on an incoming signal, software can determine the period and/or pulse width of the signal. To measure a period, two successive edges of the same polarity are captured. To measure a pulse width, two alternate polarity edges are captured. Software should track the overflows at the 16-bit module counter to extend its range.

Another use for the input capture function is to establish a time reference. In this case, an input capture function is used in conjunction with an output compare function. For example, to activate an output signal a specified number of clock cycles after detecting an input event (edge), use the input capture function to record the time at which the edge occurred. A number corresponding to the desired delay is added to this captured value and stored to an output compare register (see [18.8.5 TIMB Channel Registers](#)). Because both input captures and output compares are referenced to the same 16-bit modulo counter, the delay can be controlled to the resolution of the counter independent of software latencies.

Reset does not affect the contents of the input capture channel register (TBCHxH–TBCHxL).

18.3.3 Output Compare

With the output compare function, the TIMB can generate a periodic pulse with a programmable polarity, duration, and frequency. When the counter reaches the value in the registers of an output compare channel, the TIMB can set, clear, or toggle the channel pin. Output compares can generate TIMB CPU interrupt requests.

18.3.3.1 Unbuffered Output Compare

Any output compare channel can generate unbuffered output compare pulses as described in [18.3.3 Output Compare](#). The pulses are unbuffered because changing the output compare value requires writing the new value over the old value currently in the TIMB channel registers.

An unsynchronized write to the TIMB channel registers to change an output compare value could cause incorrect operation for up to two counter overflow periods. For example, writing a new value before the counter reaches the old value but after the counter reaches the new value prevents any compare during that counter overflow period. Also, using a TIMB overflow interrupt routine to write a new, smaller output compare value may cause the compare to be missed. The TIMB may pass the new value before it is written.

Use these methods to synchronize unbuffered changes in the output compare value on channel x:

- When changing to a smaller value, enable channel x output compare interrupts and write the new value in the output compare interrupt routine. The output compare interrupt occurs at the end of the current output compare pulse. The interrupt routine has until the end of the counter overflow period to write the new value.
- When changing to a larger output compare value, enable TIMB overflow interrupts and write the new value in the TIMB overflow interrupt routine. The TIMB overflow interrupt occurs at the end of the current counter overflow period. Writing a larger value in an output compare interrupt routine (at the end of the current pulse) could cause two output compares to occur in the same counter overflow period.

20.11 Trimmed Accuracy of the Internal Clock Generator

The unadjusted frequency of the low-frequency base clock (IBASE), when the comparators in the frequency comparator indicate zero error, can vary as much as $\pm 25\%$ due to process, temperature, and voltage. The trimming capability exists to compensate for process affects. The remaining variation in frequency is due to temperature, voltage, and change in target frequency (multiply register setting). These affects are designed to be minimal, however variation does occur. Better performance is seen with lower settings of N.

20.11.1 Trimmed Internal Clock Generator Characteristics

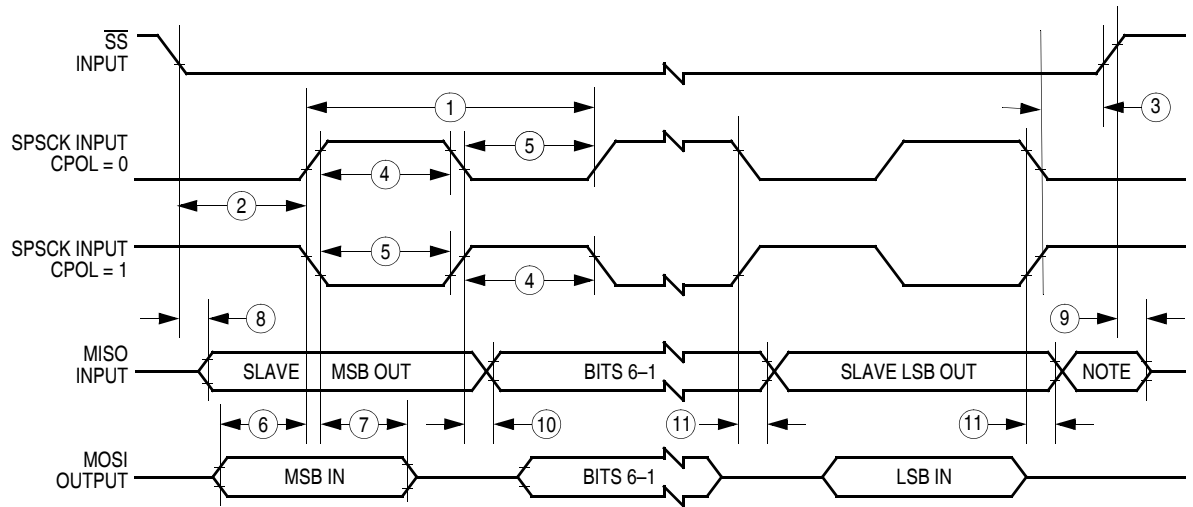
Characteristic ⁽¹⁾	Symbol	Min	Typ	Max	Unit
Absolute trimmed internal oscillator tolerance ^{(2),(3)} -40°C to 85°C -40°C to 125°C	F_{abs_tol}	—	± 2.0 ± 2.5	± 3.5 ± 5.0	%
Variation over temperature ^{(3), (4)}	V_{ar_temp}	—	0.05	0.08	%/°C
Variation over voltage ^{(3), (5)} 25°C -40°C to 85°C -40°C to 125°C	V_{ar_volt}	—	1.0 1.0 1.0	2.0 2.0 2.0	%/V

1. These specifications concern long-term frequency variation. Each measurement is taken over a 1-ms period.
2. Absolute value of variation in ICG output frequency, trimmed at nominal V_{DD} and temperature, as temperature and V_{DD} are allowed to vary for a single given setting of N.
3. Specification is characterized but not tested.
4. Variation in ICG output frequency for a fixed N and voltage
5. Variation in ICG output frequency for a fixed N

20.12 ADC10 Characteristics

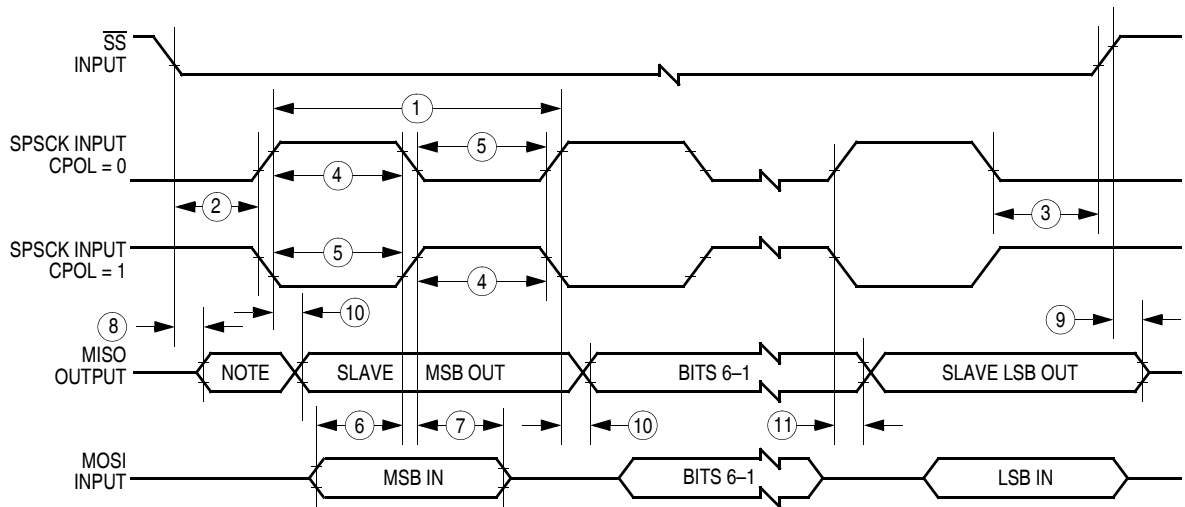
Characteristic	Conditions	Symbol	Min	Typ ⁽¹⁾	Max	Unit	Comment
Supply voltage	Absolute	V_{DD}	2.7	—	5.5	V	
Supply Current ADLPC = 1 ADLSMP = 1 ADCO = 1	$V_{DD} \leq 3.3$ V (3.0 V Typ)	$I_{DD}^{(2)}$	—	55	—	μ A	
	$V_{DD} \leq 5.5$ V (5.0 V Typ)		—	75	—		
Supply Current ADLPC = 1 ADLSMP = 0 ADCO = 1	$V_{DD} \leq 3.3$ V (3.0 V Typ)	$I_{DD}^{(2)}$	—	120	—	μ A	
	$V_{DD} \leq 5.5$ V (5.0 V Typ)		—	175	—		
Supply Current ADLPC = 0 ADLSMP = 1 ADCO = 1	$V_{DD} \leq 3.3$ V (3.0 V Typ)	$I_{DD}^{(2)}$	—	140	—	μ A	
	$V_{DD} \leq 5.5$ V (5.0 V Typ)		—	180	—		
Supply Current ADLPC = 0 ADLSMP = 0 ADCO = 1	$V_{DD} \leq 3.3$ V (3.0 V Typ)	$I_{DD}^{(2)}$	—	340	—	μ A	
	$V_{DD} \leq 5.5$ V (5.0 V Typ)		—	440	615		

— Continued on next page



Note: Not defined but normally MSB of character just received

a) SPI Slave Timing (CPHA = 0)



Note: Not defined but normally LSB of character previously transmitted

b) SPI Slave Timing (CPHA = 1)

Figure 20-4. SPI Slave Timing

A.4 Ordering Information

Table A-1. Ordering Numbers

Part Number ⁽¹⁾	Operating Temperature Range
Automotive Part Numbers⁽²⁾	
S908EY8AMFJE	-40°C to +125°C
S908EY8AVFJE	-40°C to +105°C
S908EY8ACFJE	-40°C to +85°C
Consumer and Industrial Part Numbers	
MC908EY8AMFJE	-40°C to +125°C
MC908EY8AVFJE	-40°C to +105°C
MC908EY8ACFJE	-40°C to +85°C

1. FJ = 32-pin low-profile quad flat package
2. "S" part numbers are tested in accordance with the AEC-Q100 (Automotive Electronics Council) standard.

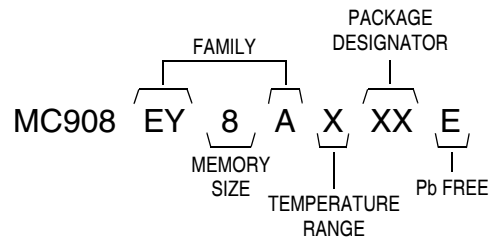


Figure A-3. Device Numbering System

B.4.2 Program

The existing 908EY16 routine uses the row programming method to program any range of addresses (starting address in H:X and ending address in RAM at LADDR, data to be programmed is in RAM starting after LADDR). This routine is interrupted every 6 bytes to service the COP.

The 908EY16A routine uses the same variables, so the call setup would be the same. In the 908EY16A, the COPD bit is checked. If COP servicing is required, then a byte-by-byte algorithm is used to program the range. If no COP servicing is required, then a combination of byte-by-byte and row programming is used for a faster algorithm. (In fact, the fastest programming would occur if the start address is the start of a row and the end address is the end of the same row. Then only the faster row programming method would be used.) To this point, the routines are compatible. However, there is a range limitation on this second algorithm. If a range is passed that crosses an xxFF to xx00 boundary, then it will fail. The byte-by-byte algorithm does not have this limitation.

Table B-1. Programming Routine Comparison

Routine	908EY16	908EY16A
Page erase	I bit set on exit	I bit restored to value at time of call
Mass erase	Selected with CTRBYT	Selected with ADDR = FLBPR
Program	No restrictions on range to be programmed	If COPD = 1, range cannot include xxFF/xx00 boundary

The maximum number of bytes required for the stack for all FLASH programming routines is now 13 bytes. In the 908EY16, the maximum number of stack locations was 12 bytes. The user should check to verify that enough stack space is set aside to accommodate this one byte increase.